Unified Measurement Framework for Embedded Real-Time Measurements

Franz Fidler

1st GENI Measurement Workshop, Madison, WI 26th June 2009

Columbia University

Lightwave Research Laboratory

Motivation

Next-generation transparent optical networks support

- mixed bit-rates
- different, co-existing modulation formats
- alien wavelengths
- dynamic optical routing
- cross-layer optimization
- . . .

Increase in network flexibility calls for relaxed physical layer performance constraints which then have to be monitored.

Major GENI Challenges

• Support embedded real-time measurements and enabling cross-layer communications/optimization for dynamic, impairment aware traffic management

• Integration of measurement resources and appropriate interfaces into substrate and control plane framework(s) within the GENI prototyping efforts

• Evaluation of performance impact under several scenarios of bidirectional cross-layer information exchange

• Monitoring of underlying physical layer conditions during experiments



Measurements as a GENI Resource (Examples, there is much more)

Infinera DTN	Adva Optical Networking	Ekinops	Polatis fiber switch	NetFPGA
Bit error counter (FEC) optical power monitor	Bit error counter (FEC) optical power monitor	Bit error counter (FEC)	Optical power monitor Optical power control	Freely programmable FPGA
Proto-GENI BEN	MAX GpENI	GpENI	BEN	SSP Overlay Proto-GENI

Milestone 1, http://groups.geni.net/geni/wiki/Embedded Real-Time Measurements

Unified Measurement Framework Requirements



Present a uniform view of measurement capabilities within the substrate and make them sliceable/accessible.

Unified Measurement Framework Interface Specifications



Milestone 3, http://groups.geni.net/geni/wiki/Embedded Real-Time Measurements

Unified Measurement Framework Implementation (Example)



Milestone 3, http://groups.geni.net/geni/wiki/Embedded Real-Time Measurements

SILO - Overview



Columbia University

Lightwave Research Laboratory

perfSONAR - Overview



from *perfsonar.net*

Summary

- Control and acquire measurement data in a unified way
- Abstract measurement capabilities and equipment
- Provide a single point of access for the GENI researcher (via a software framework) and the control framework (via NDL/RSpecs)
- Enable basic processing of the measurement data
- Provide some storage capacity
- Allow for easy reconfiguration
- Reduce software, hardware, and design overhead

